Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/618,495	OWEN ET AL.
Examiner	Art Unit
Paul Kim	2161

SEARCHED				
Class	Subclass	Date	Examiner	
707	100	1/5/2006	PK	
707	101	1/5/2006	PK	
711	100	1/5/2006	PK	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NO)
	DATE	EXMR
See Attached EAST Search History	1/5/2006	PK
	1/5/2006	